

## Product Summary

| Device | BV <sub>DSS</sub> | R <sub>DS(ON)</sub> Max        | I <sub>D</sub> Max<br>T <sub>A</sub> = +25°C<br>(Notes 7 & 9) |
|--------|-------------------|--------------------------------|---|
| Q1     | 40V               | 45mΩ @ V <sub>GS</sub> = 10V   | 5.8A  |
|        |                   | 60mΩ @ V <sub>GS</sub> = 4.5V  | 4.2A  |
| Q2     | -40V              | 45mΩ @ V <sub>GS</sub> = -10V  | -5.8A   |
|        |                   | 60mΩ @ V <sub>GS</sub> = -4.5V | -4.2A   |

## Description and Applications

This MOSFET is designed to meet the stringent requirements of Automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

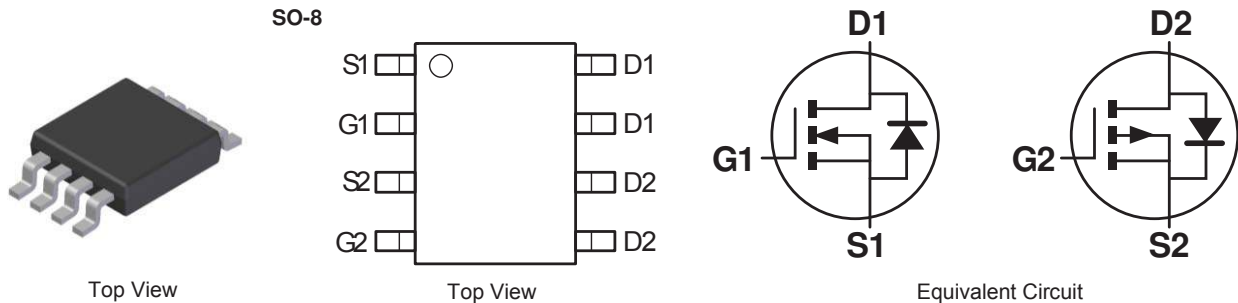
- 3-Phase BLDC Motor
- CCFL Backlighting

## Features and Benefits

- Matched N & P R<sub>DS(ON)</sub> – Minimizes Power Losses
- Fast Switching – Minimizes Switching Losses
- Dual Device – Reduces PCB Area
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. “Green” Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability PPAP Capable (Note 4)**

## Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, “Green” Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (Ⓔ)
- Weight: 0.074 grams (Approximate)

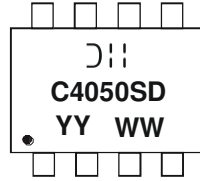


## Ordering Information (Note 5)

| Part Number    | Case | Packaging         |
|----------------|------|-------------------|
| DMC4050SSDQ-13 | SO-8 | 2,500/Tape & Reel |

- Notes:
1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
  2. See [http://www.diodes.com/quality/lead\\_free.html](http://www.diodes.com/quality/lead_free.html) for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to [http://www.diodes.com/quality/product\\_compliance\\_definitions/](http://www.diodes.com/quality/product_compliance_definitions/).
  5. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

## Marking Information



D I = Manufacturer's Marking  
 C4050SD = Product Type Marking Code  
 YYWW = Date Code Marking  
 YY or YY = Year (ex: 16 = 2016)  
 WW = Week (01 - 53)

## Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

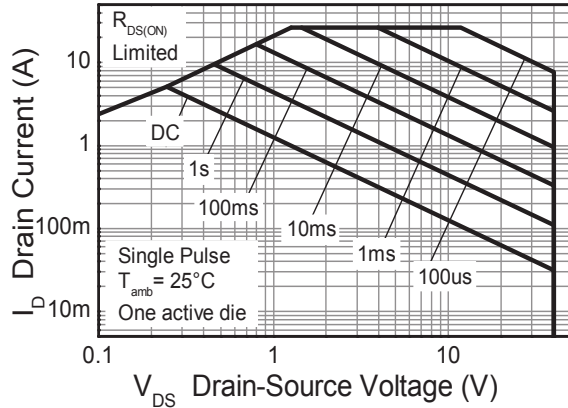
| Characteristic                         |                       | Symbol                               | N-Channel - Q1  | P-Channel - Q2 | Units |       |
|--|-----------------------|--------------------------------------|-----------------|----------------|-------|-------|
| Drain-Source Voltage                   |                       | V <sub>DSS</sub>                     | 40              | -40            | V     |       |
| Gate-Source Voltage                    |                       | V <sub>GSS</sub>                     | ±20             | ±20            |       |       |
| Continuous Drain Current               | V <sub>GS</sub> = 10V | (Notes 7 & 9)                        | 5.8             | -5.8           | A     |       |
|  |                       | T <sub>A</sub> = +70°C (Notes 7 & 9) | 4.38            | -4.52          |       |       |
|  |                       | (Notes 6 & 9)                        | 4.2             | -4.2           |       |       |
|  |                       | (Notes 6 & 10)                       | 5.3             | -5.3           |       |       |
| Pulsed Drain Current                   | V <sub>GS</sub> = 10V | (Notes 8 & 9)                        | I <sub>DM</sub> | 24.1           |       | -24.9 |
| Continuous Source Current (Body Diode) |                       | (Notes 7 & 9)                        | I <sub>S</sub>  | 2.5            |       | -2.5  |
| Pulsed Source Current (Body Diode)     |                       | (Notes 8 & 9)                        | I <sub>SM</sub> | 24.1           | -24.9 |       |

## Thermal Characteristics

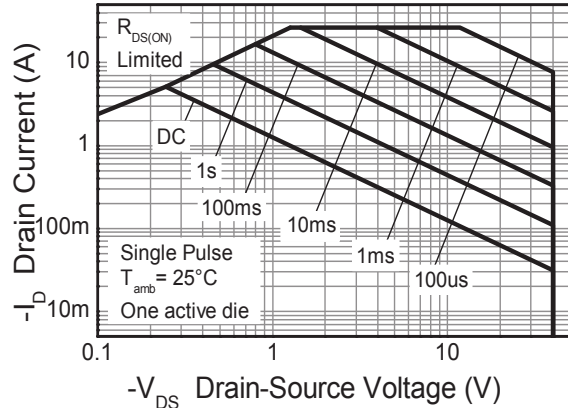
| Characteristic                              |                | Symbol                            | N-Channel - Q1 | P-Channel - Q2 | Unit |
|---|----------------|-----------------------------------|----------------|----------------|------|
| Power Dissipation<br>Linear Derating Factor | (Notes 6 & 9)  | P <sub>D</sub>                    | 1.25           | 10             | W    |
|   | (Notes 6 & 10) |                                   | 1.8            | 14.3           |      |
|   | (Notes 7 & 9)  |                                   | 2.14           | 17.2           |      |
| Thermal Resistance, Junction to Ambient     | (Notes 6 & 9)  | R <sub>θJA</sub>                  | 100            |                | °C/W |
|   | (Notes 6 & 10) |                                   | 70             |                |      |
|   | (Notes 7 & 9)  |                                   | 58             |                |      |
| Thermal Resistance, Junction to Lead        |                | R <sub>θJL</sub>                  | 51             |                | °C   |
| Operating and Storage Temperature Range     |                | T <sub>J</sub> , T <sub>STG</sub> | -55 to +150    |                |      |

- Notes:
6. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
  7. Same as Note (6), except the device is measured at t ≤ 10 sec.
  8. Same as Note (6), except the device is pulsed with D = 0.02 and pulse width 300µs.
  9. For a dual device with one active die.
  10. For a device with two active die running at equal power.
  11. Thermal resistance from junction to solder-point (at the end of the drain lead).

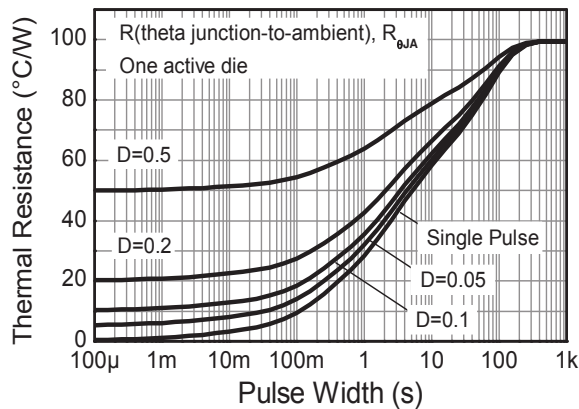
**Thermal Characteristics** (Continued)



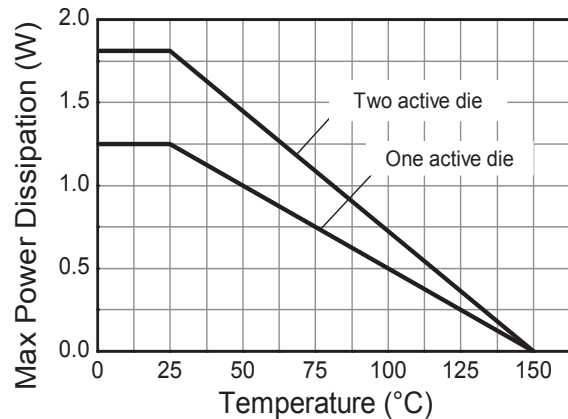
**N-channel Safe Operating Area**



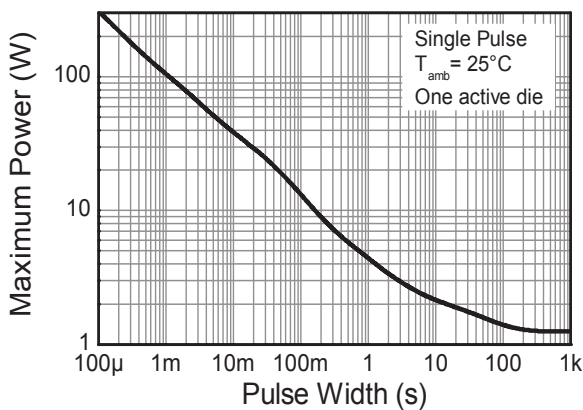
**P-channel Safe Operating Area**



**Transient Thermal Impedance**



**Derating Curve**



**Pulse Power Dissipation**

**Electrical Characteristics** (Q1 N-Channel) (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

| Characteristic  | Symbol       | Min | Typ     | Max       | Unit       | Test Condition                                      |
|---|--------------|-----|---------|-----------|------------|---|
| <b>OFF CHARACTERISTICS</b> (Note 12)                      |              |     |         |           |            |   |
| Drain-Source Breakdown Voltage                            | $BV_{DSS}$   | 40  | —       | —         | V          | $V_{GS} = 0V, I_D = 250\mu A$                       |
| Zero Gate Voltage Drain Current $T_J = +25^\circ\text{C}$ | $I_{DSS}$    | —   | —       | 1.0       | $\mu A$    | $V_{DS} = 40V, V_{GS} = 0V$                         |
| Gate-Source Leakage                                       | $I_{GSS}$    | —   | —       | $\pm 100$ | nA         | $V_{GS} = \pm 20V, V_{DS} = 0V$                     |
| <b>ON CHARACTERISTICS</b> (Note 12)                       |              |     |         |           |            |   |
| Gate Threshold Voltage                                    | $V_{GS(TH)}$ | 0.8 | 1.3     | 1.8       | V          | $V_{DS} = V_{GS}, I_D = 250\mu A$                   |
| Static Drain-Source On-Resistance                         | $R_{DS(ON)}$ | —   | 20      | 45        | m $\Omega$ | $V_{GS} = 10V, I_D = 3A$                            |
|   |              |     | 33      | 60        |            | $V_{GS} = 4.5V, I_D = 3A$                           |
| Forward Transfer Admittance                               | $ Y_{FS} $   | —   | 12.6    | —         | S          | $V_{DS} = 5V, I_D = 3A$                             |
| Diode Forward Voltage (Note 12)                           | $V_{SD}$     | —   | 0.7     | 1.0       | V          | $V_{GS} = 0V, I_S = 1A$                             |
| <b>DYNAMIC CHARACTERISTICS</b> (Note 13)                  |              |     |         |           |            |   |
| Input Capacitance   | $C_{ISS}$    | —   | 1,790.8 | —         | pF         | $V_{DS} = 20V, V_{GS} = 0V,$<br>$f = 1.0\text{MHz}$ |
| Output Capacitance  | $C_{OSS}$    | —   | 160.6   | —         | pF         |   |
| Reverse Transfer Capacitance                              | $C_{RSS}$    | —   | 120.5   | —         | pF         |   |
| Gate Resistance   | $R_G$        | —   | 1.03    | —         | $\Omega$   | $V_{DS} = 0V, V_{GS} = 0V, f = 1\text{MHz}$         |
| Total Gate Charge   | $Q_G$        | —   | 37.56   | —         | nC         | $V_{GS} = 10V, V_{DS} = 20V,$<br>$I_D = 3A$         |
| Gate-Source Charge  | $Q_{GS}$     | —   | 7.8     | —         | nC         |   |
| Gate-Drain Charge   | $Q_{GD}$     | —   | 6.6     | —         | nC         |   |
| Turn-On Delay Time  | $t_{D(ON)}$  | —   | 8.08    | —         | ns         | $V_{GS} = 10V, V_{DS} = 20V,$<br>$I_D = 3A$         |
| Turn-On Rise Time   | $t_R$        | —   | 15.14   | —         | ns         |   |
| Turn-Off Delay Time                                       | $t_{D(OFF)}$ | —   | 24.29   | —         | ns         |   |
| Turn-Off Fall Time  | $t_F$        | —   | 5.27    | —         | ns         |   |

**Electrical Characteristics** (Q2 P-Channel) (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

| Characteristic  | Symbol       | Min  | Typ      | Max       | Unit       | Test Condition                                       |
|---|--------------|------|----------|-----------|------------|--|
| <b>OFF CHARACTERISTICS</b> (Note 12)                      |              |      |          |           |            |  |
| Drain-Source Breakdown Voltage                            | $BV_{DSS}$   | -40  | —        | —         | V          | $V_{GS} = 0V, I_D = -250\mu A$                       |
| Zero Gate Voltage Drain Current $T_J = +25^\circ\text{C}$ | $I_{DSS}$    | —    | —        | -1.0      | $\mu A$    | $V_{DS} = -40V, V_{GS} = 0V$                         |
| Gate-Source Leakage                                       | $I_{GSS}$    | —    | —        | $\pm 100$ | nA         | $V_{GS} = \pm 20V, V_{DS} = 0V$                      |
| <b>ON CHARACTERISTICS</b> (Note 12)                       |              |      |          |           |            |  |
| Gate Threshold Voltage                                    | $V_{GS(TH)}$ | -0.8 | -1.3     | -1.8      | V          | $V_{DS} = V_{GS}, I_D = -250\mu A$                   |
| Static Drain-Source On-Resistance                         | $R_{DS(ON)}$ | —    | 28       | 45        | m $\Omega$ | $V_{GS} = -10V, I_D = -3A$                           |
|   |              |      | 30       | 60        |            | $V_{GS} = -4.5V, I_D = -3A$                          |
| Forward Transfer Admittance                               | $ Y_{FS} $   | —    | 16.6     | —         | S          | $V_{DS} = -5V, I_D = -3A$                            |
| Diode Forward Voltage (Note 12)                           | $V_{SD}$     | —    | -0.7     | -1.0      | V          | $V_{GS} = 0V, I_S = -1A$                             |
| <b>DYNAMIC CHARACTERISTICS</b> (Note 13)                  |              |      |          |           |            |  |
| Input Capacitance   | $C_{ISS}$    | —    | 1,643.17 | —         | pF         | $V_{DS} = -20V, V_{GS} = 0V,$<br>$f = 1.0\text{MHz}$ |
| Output Capacitance  | $C_{OSS}$    | —    | 179.13   | —         | pF         |  |
| Reverse Transfer Capacitance                              | $C_{RSS}$    | —    | 127.82   | —         | pF         |  |
| Gate Resistance   | $R_G$        | —    | 6.43     | —         | $\Omega$   | $V_{DS} = 0V, V_{GS} = 0V, f = 1\text{MHz}$          |
| Total Gate Charge   | $Q_G$        | —    | 33.66    | —         | nC         | $V_{GS} = -10V, V_{DS} = -20V,$<br>$I_D = -3A$       |
| Gate-Source Charge  | $Q_{GS}$     | —    | 5.54     | —         | nC         |  |
| Gate-Drain Charge   | $Q_{GD}$     | —    | 7.30     | —         | nC         |  |
| Turn-On Delay Time  | $t_{D(ON)}$  | —    | 6.85     | —         | ns         | $V_{GS} = -10V, V_{DS} = -20V,$<br>$I_D = -3A$       |
| Turn-On Rise Time   | $t_R$        | —    | 14.72    | —         | ns         |  |
| Turn-Off Delay Time                                       | $t_{D(OFF)}$ | —    | 53.65    | —         | ns         |  |
| Turn-Off Fall Time  | $t_F$        | —    | 30.86    | —         | ns         |  |

Notes: 12. Short duration pulse test used to minimize self-heating effect.  
13. Guaranteed by design. Not subject to production testing.

**Typical Characteristics** (Q1 N-Channel)

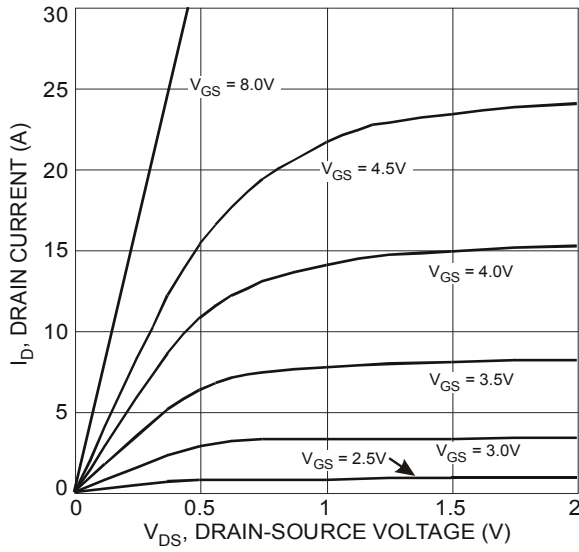


Fig. 1 Typical Output Characteristic

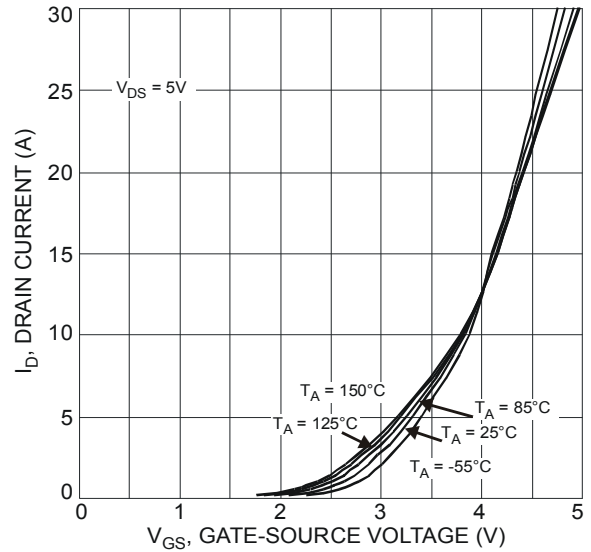


Fig. 2 Typical Transfer Characteristic

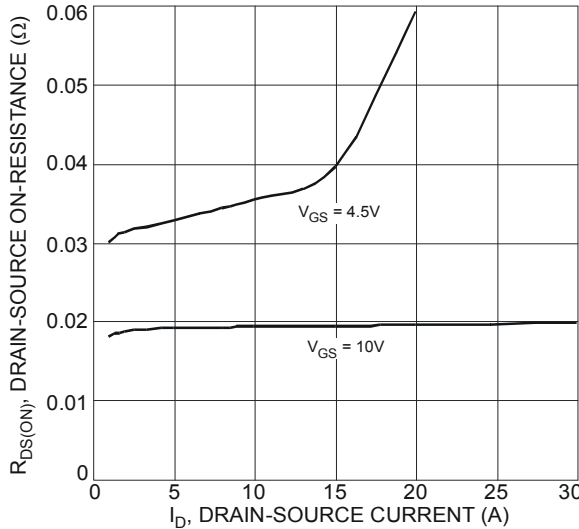


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

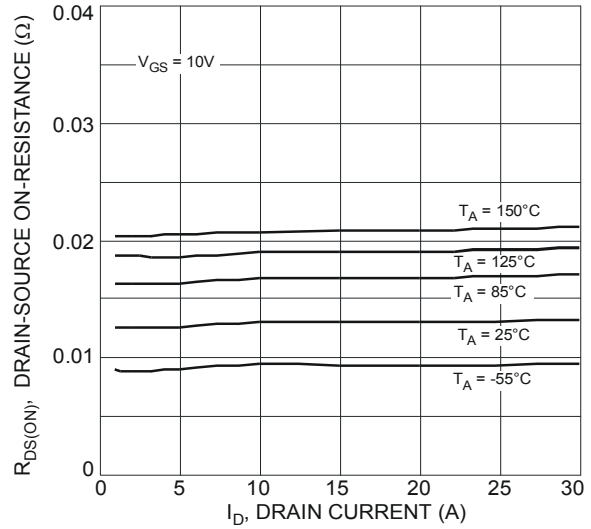


Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

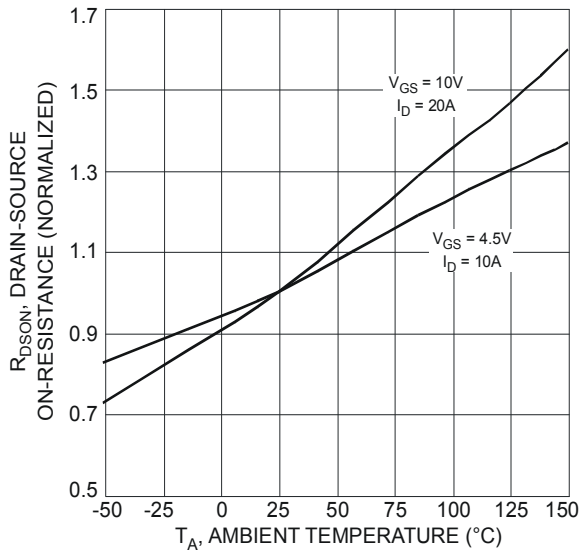


Fig. 5 On-Resistance Variation with Temperature

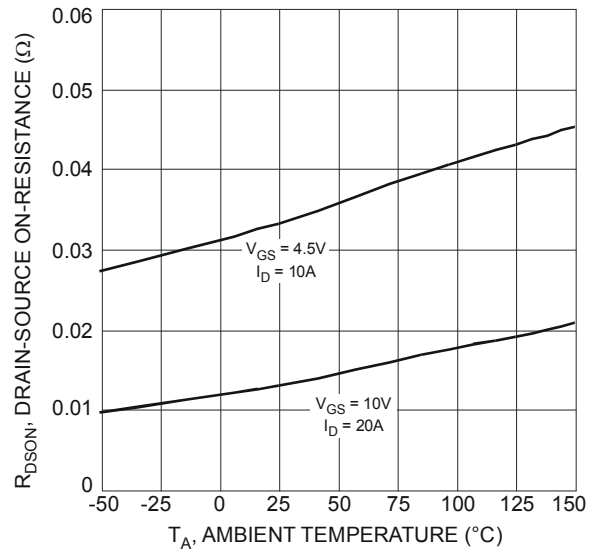


Fig. 6 On-Resistance Variation with Temperature

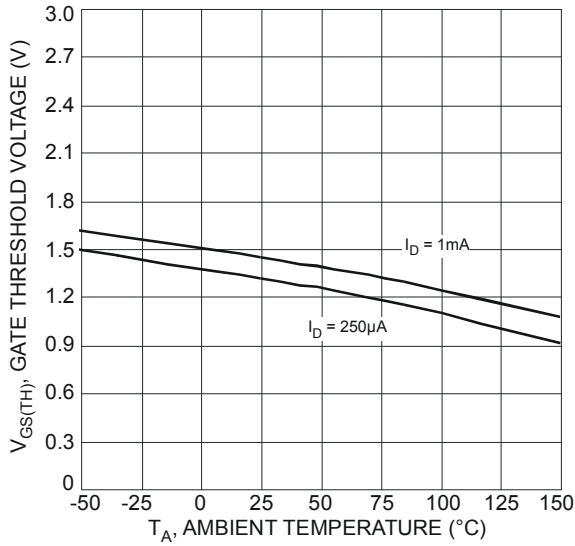


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

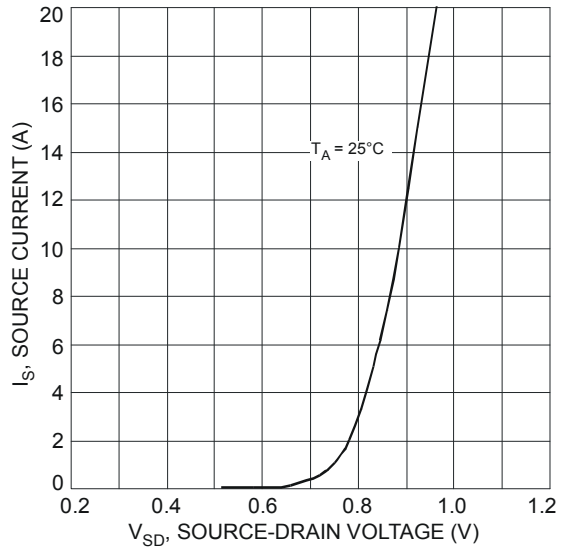


Fig. 8 Diode Forward Voltage vs. Current

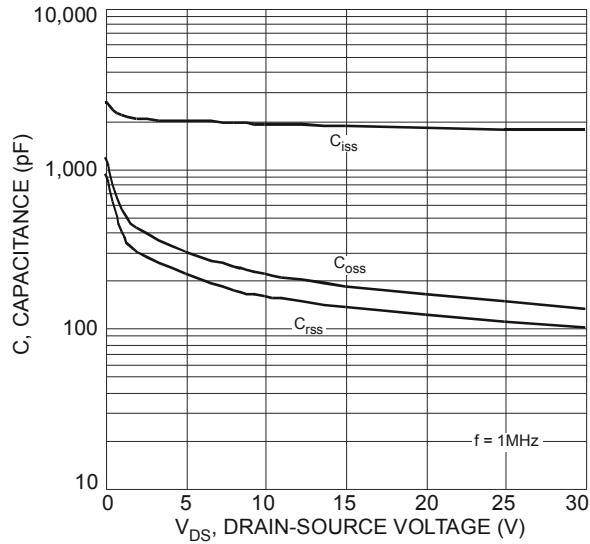


Fig. 9 Typical Total Capacitance

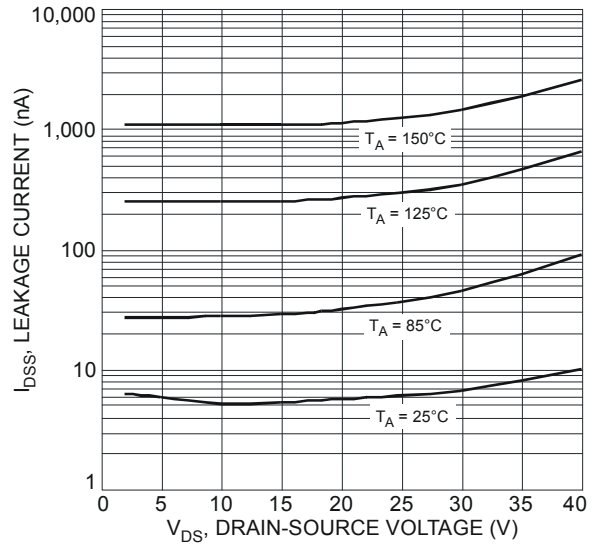


Fig. 10 Typical Leakage Current vs. Drain-Source Voltage

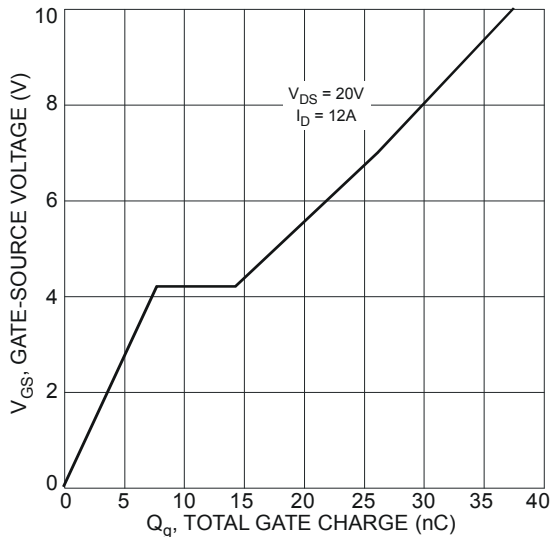


Fig. 11 Gate-Charge Characteristics

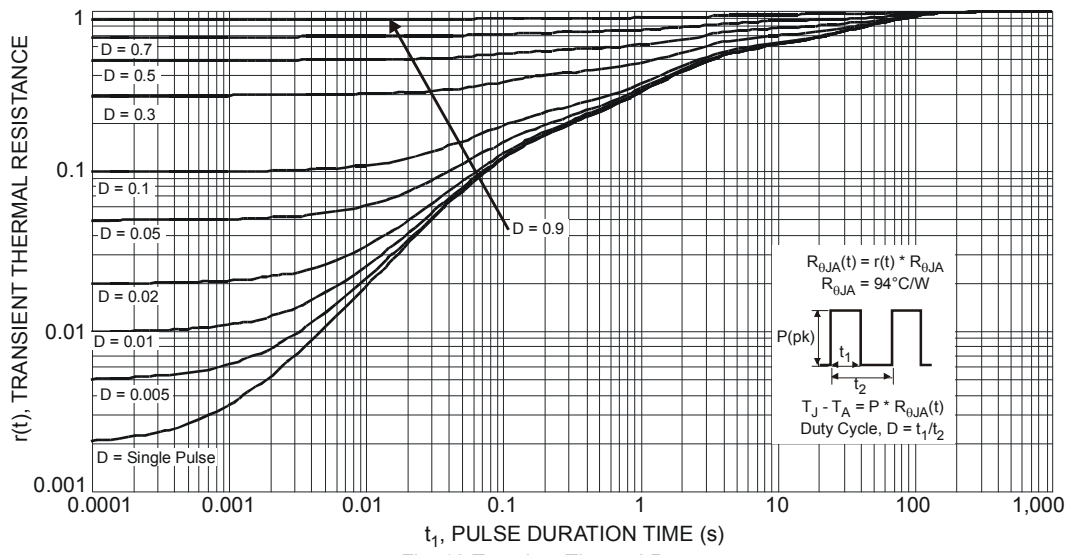


Fig. 12 Transient Thermal Response

**Typical Characteristics (Q2 P-Channel)**

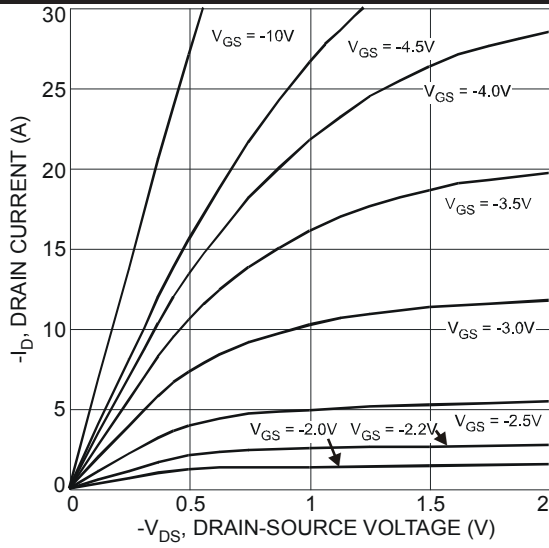


Fig. 13 Typical Output Characteristic

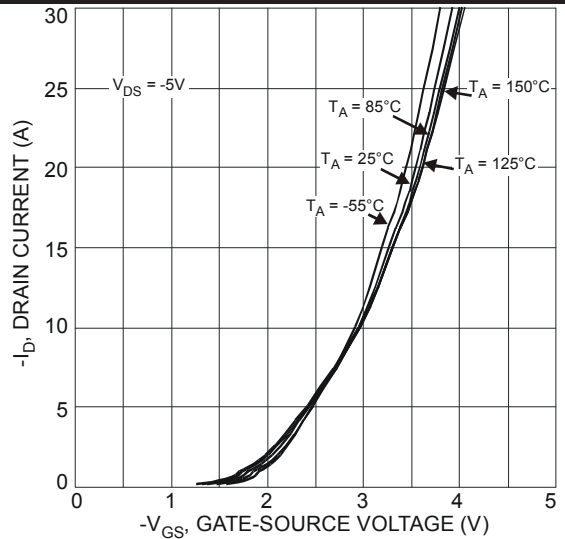


Fig. 14 Typical Transfer Characteristic

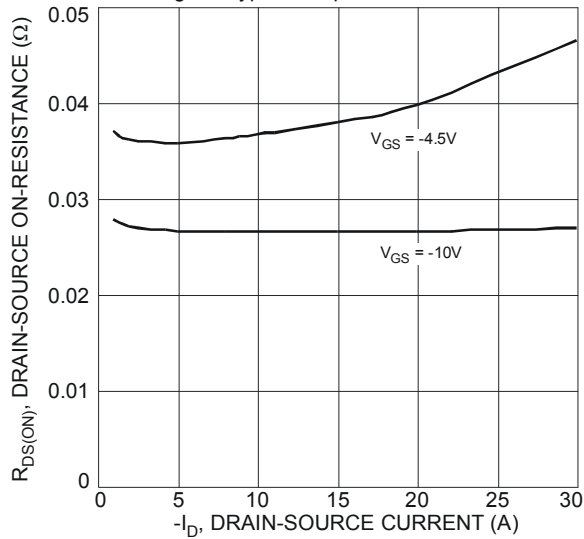


Fig. 15 Typical On-Resistance vs. Drain Current and Gate Voltage

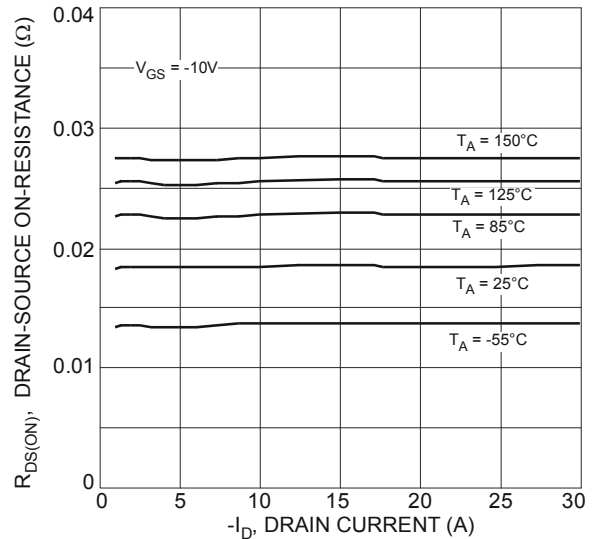


Fig. 16 Typical On-Resistance vs. Drain Current and Temperature

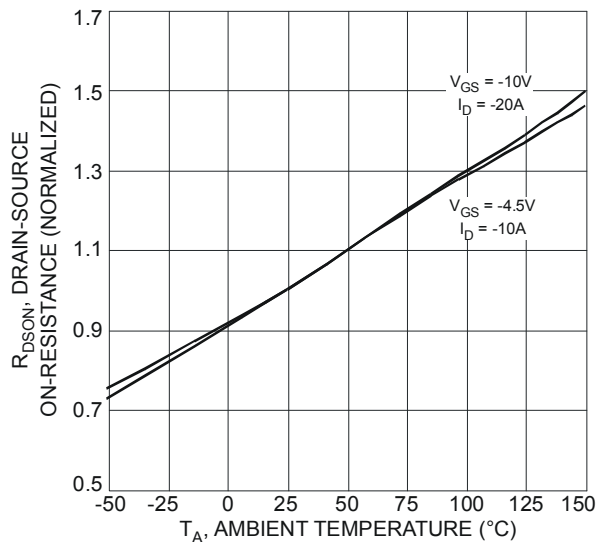


Fig. 17 On-Resistance Variation with Temperature

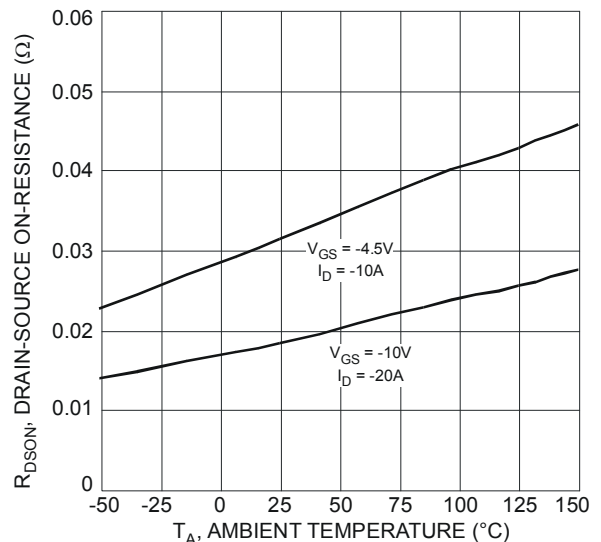


Fig. 18 On-Resistance Variation with Temperature



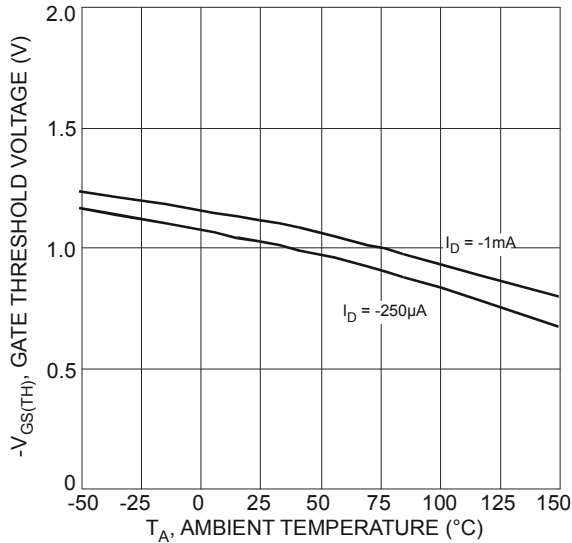


Fig. 19 Gate Threshold Variation vs. Ambient Temperature

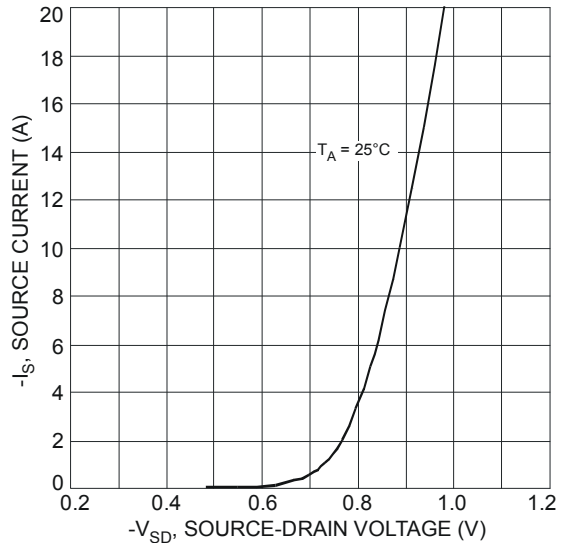


Fig. 20 Diode Forward Voltage vs. Current

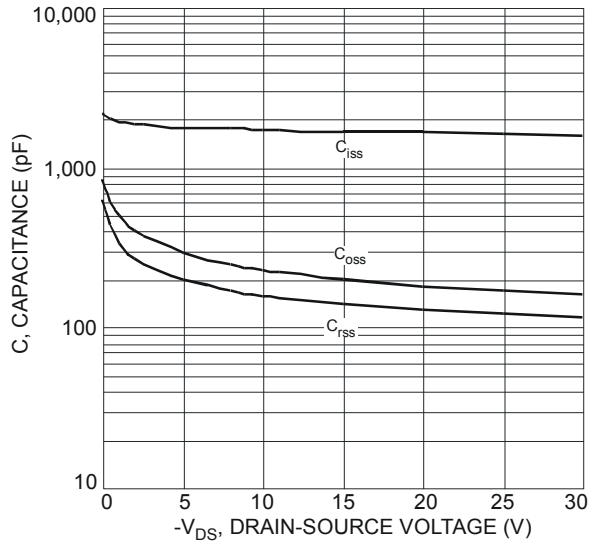


Fig. 21 Typical Total Capacitance

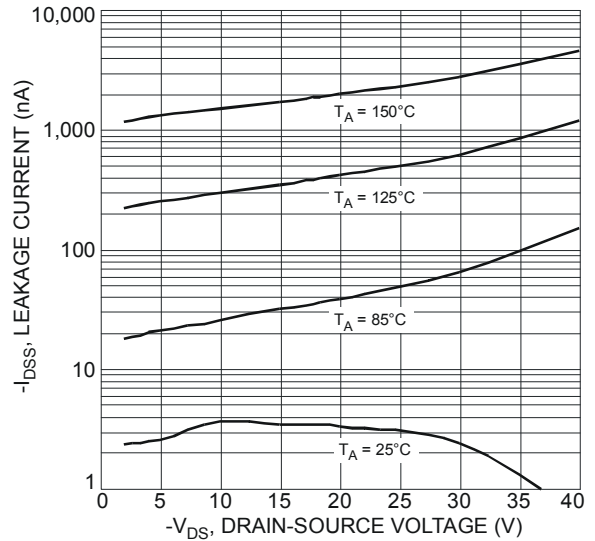


Fig. 22 Typical Leakage Current vs. Drain-Source Voltage

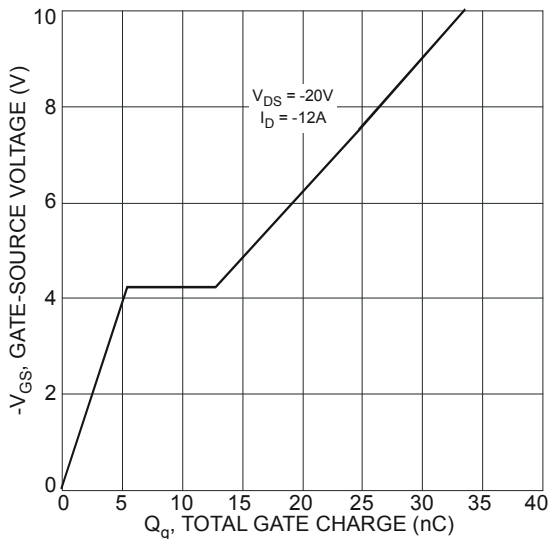


Fig. 23 Gate-Charge Characteristics

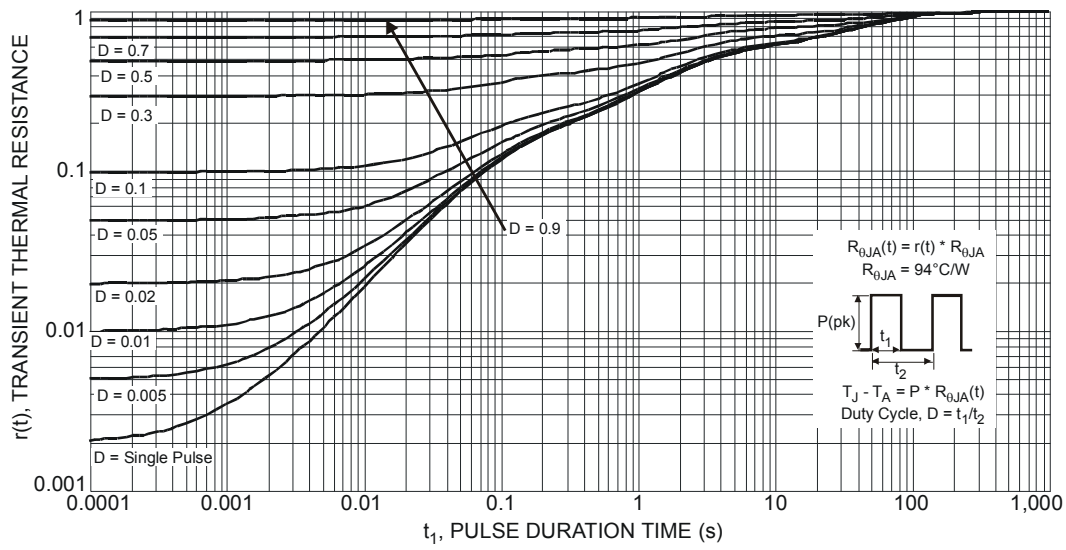
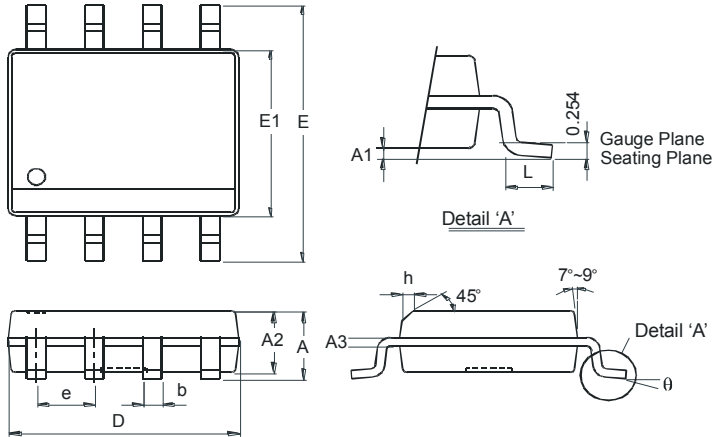


Fig. 24 Transient Thermal Response

**Package Outline Dimensions**

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

**SO-8**

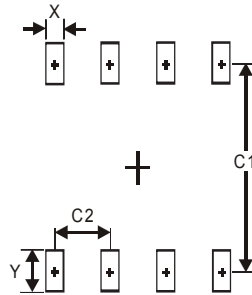


| SO-8                        |          |      |
|-----------------------------|----------|------|
| Dim                         | Min      | Max  |
| A                           | -        | 1.75 |
| A1                          | 0.10     | 0.20 |
| A2                          | 1.30     | 1.50 |
| A3                          | 0.15     | 0.25 |
| b                           | 0.3      | 0.5  |
| D                           | 4.85     | 4.95 |
| E                           | 5.90     | 6.10 |
| E1                          | 3.85     | 3.95 |
| e                           | 1.27 Typ |      |
| h                           | -        | 0.35 |
| L                           | 0.62     | 0.82 |
| θ                           | 0°       | 8°   |
| <b>All Dimensions in mm</b> |          |      |

**Suggested Pad Layout**

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

**SO-8**



| Dimensions | Value (in mm) |
|------------|---------------|
| X          | 0.60          |
| Y          | 1.55          |
| C1         | 5.4           |
| C2         | 1.27          |

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1. are intended to implant into the body, or
2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

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